

## AD9005B

### FEATURES

Complete 12-Bit A/D Converter  
Includes Track-and-Hold, Reference and Timing  
Bipolar Analog Input ( $\pm 1.024$  V)  
Up to 10 MSPS Sampling Rate  
Low Power Dissipation: 3.2 W  
Low Harmonic Distortion  
MIL-STD-883-Compliant Versions Available

### APPLICATIONS

Radar  
Digital Receivers  
Electro-Optics  
Medical Scanners  
Signal Intelligence  
Spectrum Analyzers

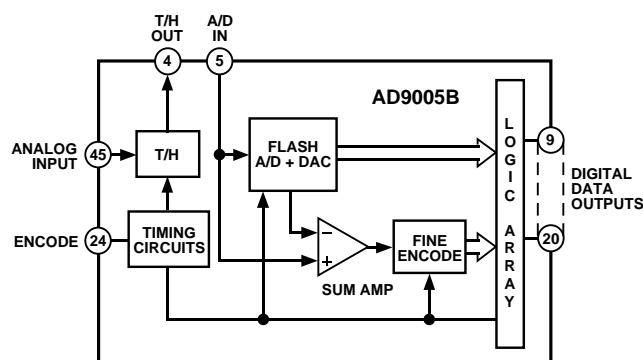
### GENERAL DESCRIPTION

The AD9005B is a complete 12-bit A/D converter that includes on-board track-and-hold amplifier, voltage reference, and timing circuits. Featuring sampling rates from dc to 10 MSPS, the AD9005B uses a subranging converter architecture to achieve high speed and high resolution. Dynamic performance includes an SNR of 64 dB and harmonic distortion of  $-72$  dBc with a 4.3 MHz analog input.

This unit replaces its predecessor, the AD9005A. The AD9005B uses a higher level of integration than the earlier design to provide increased performance, better reliability and reduced cost.

The AD9005B requires only  $+5$  V and  $-5.2$  V supplies (eliminating the  $+15$  V and  $-15$  V requirements of the AD9005A). The AD9005B will operate without board modification in

### FUNCTIONAL BLOCK DIAGRAM



AD9005A sockets because  $+15$  V and  $-15$  V pins are not internally connected. All grades are fully tested for dynamic performance.

Critical to the performance of the AD9005B is the use of advanced bipolar integrated circuits, custom designed for this device and manufactured by Analog Devices. The AD9005B is TTL-compatible with offset binary outputs. It is available in a 46-lead hermetic metal DIP in two temperature ranges:  $0^{\circ}\text{C}$  to  $+70^{\circ}\text{C}$  commercial range and  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  military range (case temperature).

### REV. 0

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# AD9005B—SPECIFICATIONS

## ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

Positive Supply Voltage (+V <sub>S</sub> )	+6 V
Negative Supply Voltage (−V <sub>S</sub> )	−6 V
Analog Input Voltage (Pin 45)	±3.0 V dc
Digital Input Voltage	−0.5 V to +V <sub>S</sub>
Digital Output Current	4 mA

## Operating Temperature Range (Case)

AD9005BKM	0°C to +70°C
AD9005BTM	−55°C to +125°C
Storage Temperature Range	−65°C to +150°C
Junction Temperature <sup>2</sup>	+175°C
Lead Soldering Temperature (10 sec)	+300°C

## ELECTRICAL CHARACTERISTICS (+V<sub>S</sub> = +5 V, −V<sub>S</sub> = −5.2 V, unless otherwise noted)

Parameter	Temp	Test Level	Commercial 0°C to +70°C AD9005BKM			Military −55°C to +125°C AD90005BTM/KJ			Units
			Min	Typ	Max	Min	Typ	Max	
RESOLUTION	+25°C	I	12			12			Bits
LSB Weight	Full	V		0.5			0.5		mV
STATIC ACCURACY									
Differential Nonlinearity	+25°C	I	−1.0	±0.5	+1.0	−1.0	±0.5	+1.0	LSB
	Full	VI	−1.0		+1.5	−1.0		+1.5	LSB
Integral Nonlinearity	+25°C	I		±1.0	±1.25		±1.0	±1.25	LSB
	Full	IV			±2.25			±2.25	LSB
No Missing Codes	Full	VI	GUARANTEED			GUARANTEED			
Gain Error	+25°C	I		±0.5	±1.0		±0.5	±1.0	% FS
	Full	VI			±2.0			±2.0	% FS
Offset Error	+25°C	I		±4	±15		±4	±15	mV
	Full	VI			±30			±40	mV
ANALOG INPUT									
Input Voltage Range	Full	V		±1.024			±1.024		V p-p
Input Resistance	Full	VI	900	1000	1100	900	1000	1100	Ω
Input Capacitance	+25°C	V		8			8		pF
Large Signal Input Bandwidth <sup>3</sup>	Full	V		38			38		MHz
DYNAMIC CHARACTERISTICS <sup>5</sup>									
Maximum Conversion Rate	Full	I	10			10			MSPS
Output Data Delay <sup>6, 9</sup> (t <sub>PD</sub> )	+25°C	V		90			90		ns
Aperture Delay (t <sub>A</sub> )	+25°C	V		9			9		ns
Aperture Uncertainty	+25°C	IV		10	20		10	20	ps rms
Transient Response (to ±1 LSB) <sup>7</sup>	+25°C	IV			120			120	ns
Overvoltage Recovery Time <sup>8</sup> (to ±1 LSB)	+25°C	IV			250			250	ns
Harmonic Distortion <sup>10, 4</sup>									
F <sub>IN</sub> = 540 kHz	+ 25°C	IV	−73	−78		−73	−78		dBc
F <sub>IN</sub> = 2.3 MHz	+25°C	I	−68	−72		−68	−72		dBc
	Full	VI	−67			−66			dBc
F <sub>IN</sub> = 4.3 MHz	+25°C	I	−66	−72		−66	−72		dBc
	Full	VI	−65			−63			dBc
Signal to Noise Ratio <sup>11, 4</sup>									
F <sub>IN</sub> = 540 kHz	+25°C	IV	65	67		65	67		
F <sub>IN</sub> = 2.3 MHz	+25°C	I	63	65		63	65		dB
	Full	VI	63			60			dB
F <sub>IN</sub> = 4.3 MHz	+25°C	I	62	64		62	64		dB
	Full	VI	61			60			dB
Two-Tone Intermodulation Distortion <sup>12</sup>									
F <sub>IN</sub> = 2.2 MHz + 2.3 MHz	+25°C	V		−75			−75		dBc
ENCODE INPUT <sup>14</sup>									
Logic “1” Voltage	Full	IV	2.0			2.0			V
Logic “0” Voltage	Full	IV			0.8			0.8	V
Logic “1” Current	Full	I			150			150	μA
Logic “0” Current	Full	I			150			150	μA
Input Capacitance	+25°C	V		5			5		pF
Encode Pulse Width (High)	+25°C	IV	25			25			ns

Parameter	Temp	Test Level	Commercial 0°C to +70°C AD9005BKM			Military −55°C to +125°C AD9005BTM			Units
			Min	Typ	Max	Min	Typ	Max	
DIGITAL OUTPUTS									
Logic “1” Voltage (2 mA Source)	Full	I	2.4			2.4			V
Logic “0” Voltage (4 mA Sink)	Full	I			0.4			0.4	V
Logic Coding	Full	IV	Offset Binary			Offset Binary			
POWER SUPPLY									
Supply Voltage +V <sub>S</sub>	Full	VI	4.75	5.0	5.25	4.75	5.0	5.25	V
Supply Current Analog +V <sub>S</sub>	Full	VI		180	240		180	240	mA
Supply Current Digital +V <sub>S</sub>	Full	VI		43	80		43	80	mA
Supply Voltage −V <sub>S</sub>	Full	VI	−4.95	−5.2	−5.45	−4.95	−5.2	−5.45	V
Supply Current Analog −V <sub>S</sub>	Full	VI		210	320		210	320	mA
Supply Current Digital −V <sub>S</sub>	Full	VI		65	110		65	110	mA
Nominal Power Dissipation	Full	VI		3.2	4.0		3.2	4.0	W
PSRR <sup>13, 15</sup>	+25°C	I		0.01	0.02		0.01	0.02	%/%

## NOTES

<sup>1</sup>Absolute maximum ratings are limiting values, to be applied individually, and beyond which the serviceability of the circuit may be impaired. Functional operation under any of these conditions is not necessarily implied. Exposure to absolute rating conditions for extended periods of time may affect device reliability.

<sup>2</sup>Maximum junction temperature should not be allowed to exceed +175°C. Hybrid thermal model:

$$T_{\text{JUNCTION}} = T_{\text{AMBIENT}} + P_{\text{DISSIPATION}} \times (\theta_{\text{CA}}) + T_{\text{S}} - T_{\text{C}} \text{ max}$$

where  $(T_{\text{S}} - T_{\text{C}}) \text{ max} = 10^{\circ}\text{C}$

46-lead metal DIP:  $\theta_{\text{CA}} = 14^{\circ}\text{C/W}$  in still air;

$\theta_{\text{CA}} = 6^{\circ}\text{C/W}$  with 500 LFPM air flow.

<sup>3</sup>Determined by 3 dB reduction in reconstructed output.

<sup>4</sup>Input at 1 dB below full scale.

<sup>5</sup>Measured at 10 MHz encode rate.

<sup>6</sup>Measured from ENCODE in to data out for LSB only.

<sup>7</sup>For full-scale step input; 12-bit accuracy is attained in the specified time.

<sup>8</sup>Recovers to 12-bit accuracy in specified time following 200% full-scale input voltage.

<sup>9</sup>Excludes pipeline delay of two clock cycles (see timing diagram).

<sup>10</sup>Worst case spurious in-band signal relative to input level.

<sup>11</sup>RMS signal to RMS noise, including harmonics.

<sup>12</sup>Worst case spurious in-band signal relative to level of input tones, which are both −7 dB below full scale.

<sup>13</sup>Sensitivity of full-scale gain error with respect to power supply variation within supply Min/Max limits.

<sup>14</sup>ENCODE signal rise and fall times should be less than 5 ns for normal operation. Transition from “0” to “1” initiates conversion.

<sup>15</sup>PSRR is tested over given voltage range.

Specifications subject to change without notice.

## EXPLANATION OF TEST LEVELS

## Test Level

I – 100% production tested.

II – 100% production tested at +25°C, and sample tested at specified temperatures.

III – Periodically sample tested only.

IV – Parameter is guaranteed by design and characterization testing.

V – Parameter is a typical value only.

VI – All devices are 100% production tested at +25°C. 100% production tested at temperature extremes for military temperature devices. Guaranteed, not tested, for commercial temperature range

## ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option*
AD9005BKM	0°C to +70°C	46-Lead DIP, Commercial Temperature	M-46
AD9005BTM	−55°C to + 125°C	46-Lead DIP, Military Temperature	M-46
AD9005/PCB	0°C to +70°C	AD9005 Evaluation Board	

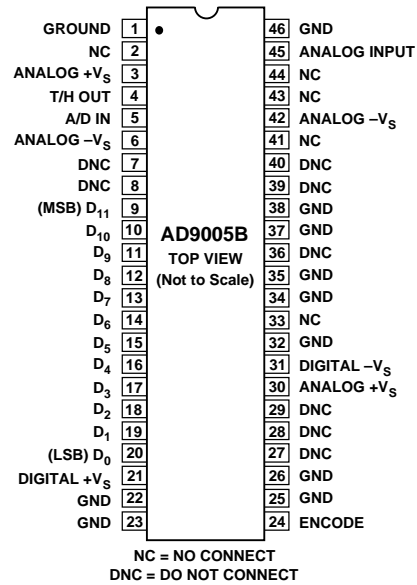
\*M = Hermetic Metal Can DIP.

# AD9005B

## OUTPUT CODING

ANALOG INPUT	D <sub>11</sub>	D <sub>10</sub>	D <sub>9</sub>	D <sub>8</sub>	D <sub>7</sub>	D <sub>6</sub>	D <sub>5</sub>	D <sub>4</sub>	D <sub>3</sub>	D <sub>2</sub>	D <sub>1</sub>	D <sub>0</sub>
≥+1.024 V	1	1	1	1	1	1	1	1	1	1	1	1
≤1.024 V	0	0	0	0	0	0	0	0	0	0	0	0

## PIN DESIGNATIONS



## PIN FUNCTION DESCRIPTIONS

Pin	Name	Description
1	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.
2	NC	Not internally connected.
3	ANALOG +V <sub>S</sub>	Positive analog supply pin. Nominally +5 V dc.
4	T/H OUT	Output of internal track-and-hold amplifier. Connect to Pin 5 for normal operation.
5	A/D IN	Input to internal A/D encoder. Connect to Pin 4 for normal operation.
6	ANALOG -V <sub>S</sub>	Negative analog supply pin. Nominally -5.2 V dc.
7, 8	DNC	Do not connect. Internal test point.
9	D <sub>11</sub> (MSB)	Most significant bit of digital output data.
10–19	D <sub>10</sub> –D <sub>1</sub>	Digital data outputs.
20	D <sub>0</sub> (LSB)	Least significant bit of digital output data.
21	DIGITAL +V <sub>S</sub>	Positive digital supply pin. Nominally +5 V dc.
22, 23	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.
24	ENCODE	Convert command. TTL compatible, rising edge triggered.
25, 26	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.
27–29	DNC	Do not connect. Internal test point.
30	ANALOG +V <sub>S</sub>	Positive analog supply pin. Nominally +5 V dc.
31	DIGITAL -V <sub>S</sub>	Negative digital supply pin. Nominally -5.2 V dc.
32	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.
33	NC	Not internally connected.
34, 35	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.
36	DNC	Do not connect. Internal test point.
37, 38	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.
39, 40	DNC	Do not connect. Internal test point.
41	NC	Not internally connected.
42	ANALOG -V <sub>S</sub>	Negative analog supply pin. Nominally 5.2 V dc.
43	NC	Not internally connected.
44	NC	Not internally connected.
45	ANALOG INPUT	Analog input. Full scale of + 1.024 V.
46	GROUND	Circuit ground. All grounds should be connected together near the AD9005B.

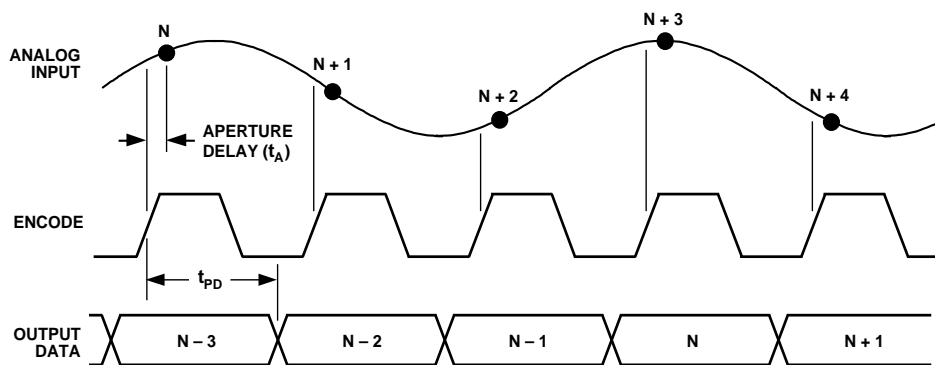


Figure 1. Timing Diagram

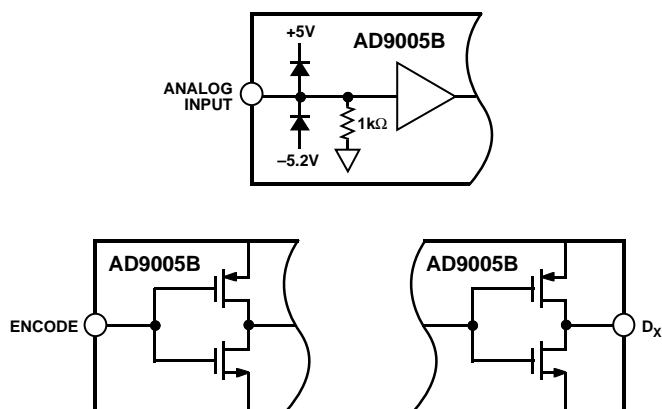


Figure 2. Equivalent Input/Output Circuits

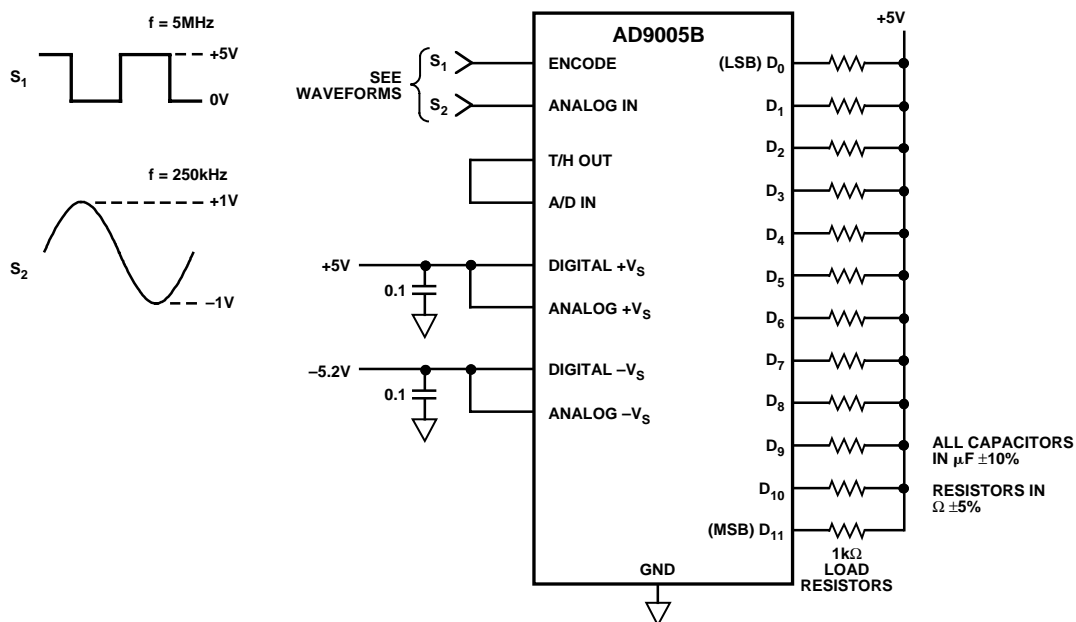


Figure 3. Burn-In Circuit

# AD9005B

## APPLICATIONS INFORMATION

The AD9005B is a complete analog-to-digital converter. The AD9005B uses a subranging A/D architecture enhanced by hybrid technology. This includes an on-board track-and-hold amplifier, on-board references, timing circuitry and output latches.

The analog input of the AD9005B is fed directly into the internal track-and-hold amplifier, thus eliminating the need for external signal conditioning in many applications. This amplifier provides low input capacitance and a bipolar ( $\pm 1.024$  V) input range. Normally reverse-biased Schottky diodes on the input provide overrange protection. If the amplitude, bandwidth or dc voltage level of the analog input signal calls for external signal conditioning, it is advisable to use an amplifier with low harmonic distortion and low noise characteristics. Selecting the amplifier may be difficult because the performance of the AD9005B will probably exceed the performance of most commercially available amplifiers. A notable exception is the AD9617, a wideband low noise current feedback amplifier. It is important to remember that band limiting the analog input signal can avoid aliasing during the A/D conversion process.

Timing in the AD9005B is critical, and careful measures must be taken to support 12-bit accuracy. One simple way to enhance

the performance of the AD9005B is to synchronize the system clock to a crystal oscillator. This will minimize any clock jitter, a must for maintaining the spectral purity of analog signals near Nyquist limits. Because the conversion cycle begins with the rising edge of the encode signal, a fast, clean, rising edge will also help to reduce any clock jitter.

When the ENCODE signal of the AD9005B goes HIGH, the internal track-and-hold enters the hold state; after 65 ns, it returns to track mode. In applications in which the AD9005B is slowly or intermittently clocked (i.e., in burst mode), the encode signal should be returned to a logic LOW state during the idle periods.

The ENCODE signal pulse width should also be adjusted so it is in the HIGH (hold) state for a minimum of 25 ns. This ensures that the T/H enters the hold mode before the A/D conversion takes place.

The AD9005B has many appealing characteristics for 12-bit A/D converter applications. Its dynamic performance is state-of-the-art in hybrid technology. Typical applications include radar, missile guidance, digital oscilloscopes, waveform analyzers, medical instrumentation, electro-optics, communications and ESM.

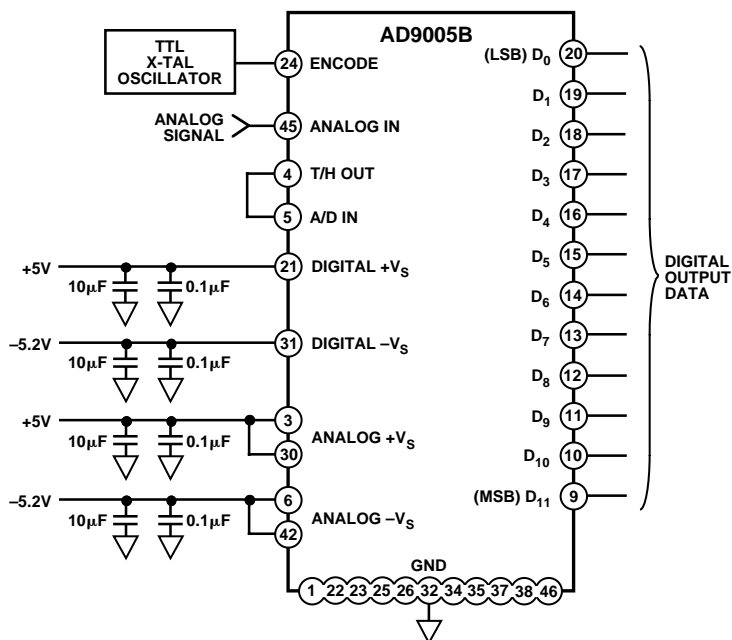


Figure 4. Typical Application

## Layout Information

The accuracy of a 12-bit converter, especially one with the dynamic performance level of the AD9005B, requires that designers pay careful attention to printed circuit board layouts. Analog signal paths should be impedance matched, with termination/load resistors at or near package connections. Analog signal paths should also be isolated from digital signal paths. Otherwise digital signals can be capacitively coupled into the analog section of the circuit, degrading the overall performance of the A/D converter.

Digital switching noise on power supplies can also degrade converter performance. Because of this noise (inherent with TTL logic), the digital power supplies of the AD9005B should be separated from the analog power supplies. In addition, each power supply should be capacitively decoupled to ground. To accomplish this, a single large value capacitor with a high resonant frequency (a 10  $\mu$ F tantalum capacitor for example) should be used on each of the AD9005B's power supplies, at or near the package. In addition, a lower value capacitor with good high frequency characteristics (a 0.1  $\mu$ F ceramic chip capacitor is recommended) should be connected to each power supply pin connection.

For applications in which only single +5 V and/or -5.2 V supplies are available, a ferrite bead, placed in series between the

analog and digital power pins, can be used to isolate the digital noise from the analog circuits.

Noise on the circuit ground is often the limiting factor in A/D converter performance. Perhaps the most critical concerns of circuit layout are the ground connections. To reduce ground noise, a two-sided printed circuit board is recommended, the component side being reserved (as much as possible) for a single, low impedance ground plane. The other side should be used for all (possible) power and signal connections. Each of the ground connections of the AD9005B should be connected to the ground plane, and most of the area under the AD9005B should be part of this ground plane. The metal case of the AD9005B is connected to ground.

Operation of the AD9005B requires that Pin 4, the output of the internal track-and-hold, be connected to Pin 5, the input to the AD9005B's A/D converter circuitry. A suggested layout, illustrating this connection, is shown below.

A final suggestion regarding circuit layout concerns the use of sockets. Ideally, parts should be soldered into boards in final designs. If sockets must be used, individual pin sockets are recommended to avoid lead inductance and capacitive coupling between adjacent pins. Pin sockets are available from Amp, part #6-330808-0.

## SUGGESTED LAYOUT

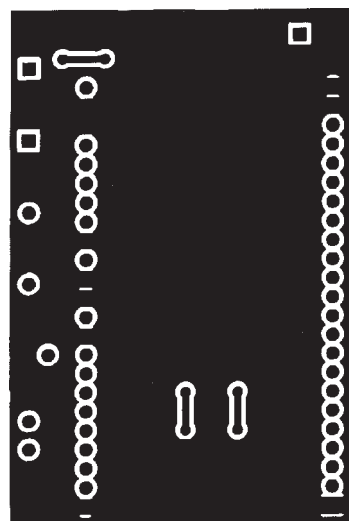


Figure 5. GND Plane Side  
(As Viewed from Top)

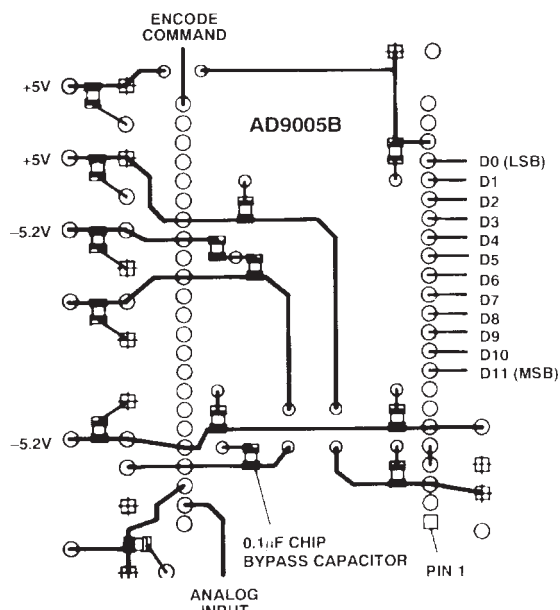


Figure 6. Solder Side  
(As Viewed from Top)

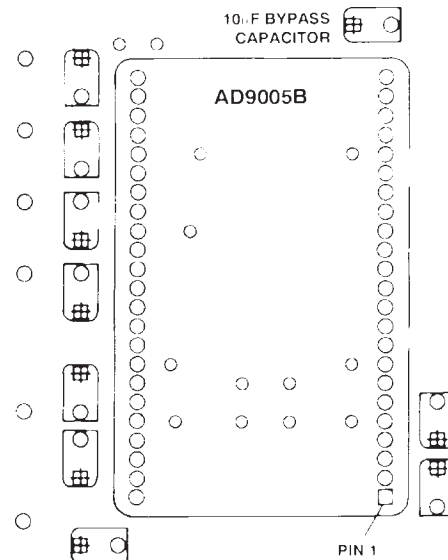


Figure 7. Component Mounting  
(As Viewed from Top)

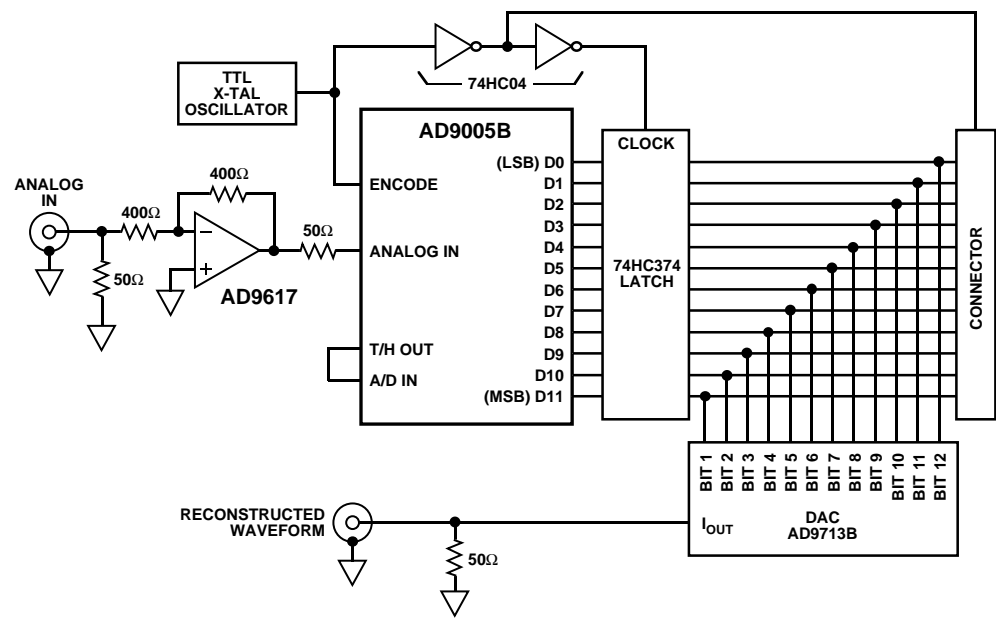


Figure 8. Evaluation Circuit

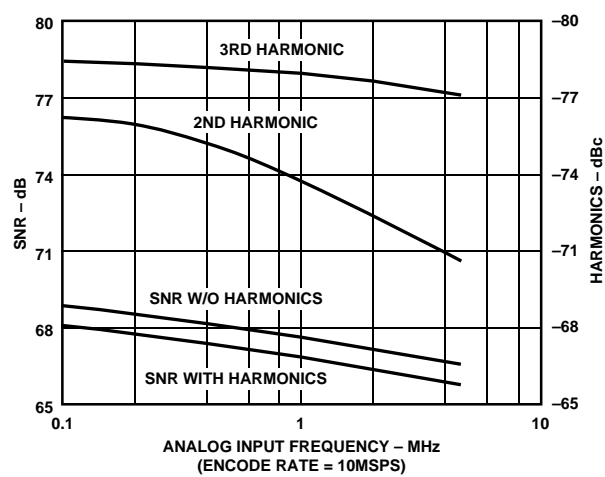


Figure 9. Dynamic Performance (@ +25°C)

**OUTLINE DIMENSIONS**  
Dimensions shown in inches and (mm).

**46-Lead Metal Dual In-Line Can**

